

Measurement of hit reconstruction efficiency and resolution of the SVD sensors

Thomas Lück for the Pisa-group

March 4th 2016



UNIVERSITÀ DI PISA

outline

- 1 Motivation and Analysis
- 2 Preliminary results
- 3 Summary and Conclusion

Goals of this analysis

use data taken at the test beam to:

- measure the resolution of the SVD sensors
- measure the hit finding efficiency of the SVD sensors

Approach

- it was not clear to us if Telescope data will be available for analysis
- from experience with previous test beam: data taken with telescope might not be usable
- prepare analysis without using an external telescope
 - use "self tracking" approach

Analysis strategy

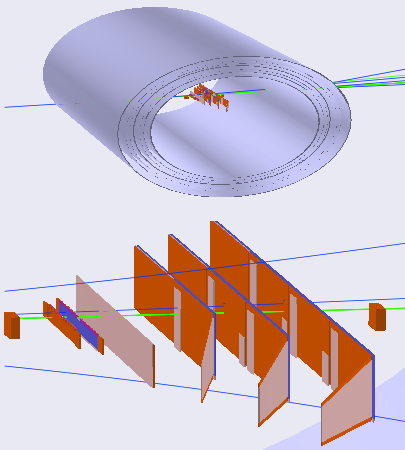
- use the basf2 software for reconstruction
- remove one SVD layer from the reconstruction (implemented by removing the SVDCluster)
- do track finding (VXDTF) and track fitting (GenFit) with one layer removed
- use the fitted GenFit track to predict the track position on the removed layer
- compare the predicted position with reconstructed position (cluster position) on the removed sensor layer:
 - measure the residual as reconstructed minus predicted position
 - use a cut and count approach to estimate the hit efficiency

Do MC-studies with the beam test geometry (basf2)

Used beam parameters:

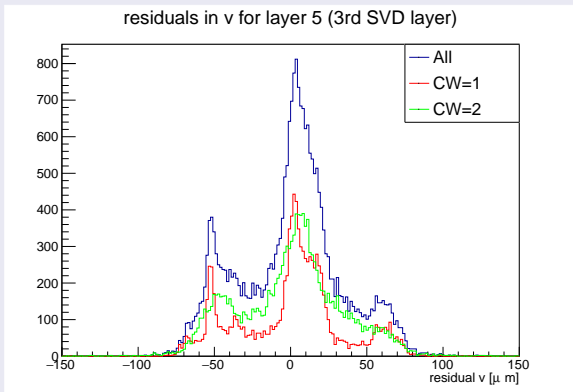
- single (primary) electron per event
- $\theta = 91^\circ$; spread $\theta = 0.005^\circ$ (σ Gaussian)
- $\phi = 0^\circ$; spread $\phi = 0.005^\circ$ (σ Gaussian)
- vertex outside Magnet
 $\vec{x} = (-100, 0, 0)cm$
- beam spot size 0.3 cm in x and z
- $p_{beam} = 6GeV$ spread 0.3GeV (σ Gaussian)

Two example events displayed



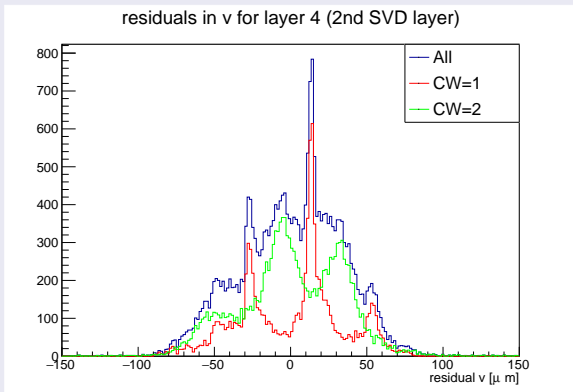
- for this example only SVD layers used (but same is observed if PXD layers are included)
- cuts applied p-value fit: $P > 0.05$; momentum
 $4.67 < p_{track} < 6.67 \text{ GeV}$

Found strange structures in the v direction (n-side pitch = $240 \mu\text{m}$)



- for this example only SVD layers used (but same is observed if PXD layers are included)
- cuts applied p-value fit: $P > 0.05$; momentum
 $5.67 < p_{\text{track}} < 6.67 \text{ GeV}$

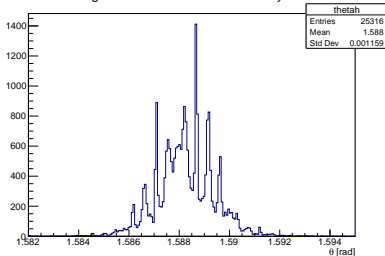
Found strange structures in the v direction (n-side pitch = $240 \mu\text{m}$)



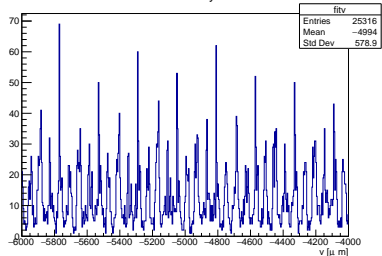
Further investigation

- fitted beam position correlated to underlying sensor structure (of other layers)
- therefore also correlated to the reconstructed position (of layer under investigation)

angle θ reconstructed track for Layer 5

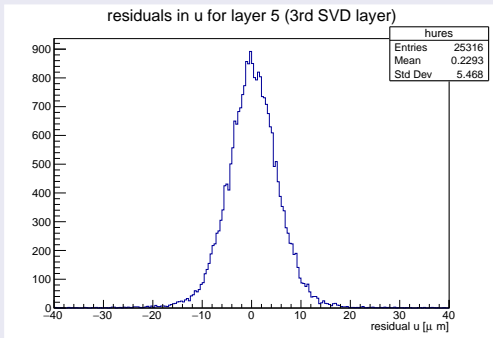


fitted v for Layer 5



- reconstructed residual in u for layer 5 $res = 5.5\mu m$
- looks good compared to digital resolution $10.8\mu m$

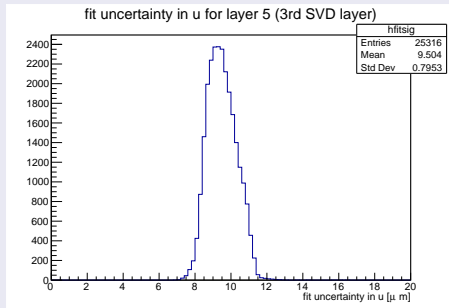
Measured residual for layer 5 u direction



- too good to be true ...

- mean fit uncertainty $\approx 9.5\mu\text{m}$
- measured residual $res = 5.5\mu\text{m}$ much better than fit uncertainty (yes, we are "that good")
- here intrinsic resolution of sensor not included
- also results for u direction not reliable (due to correlations with other layers)

Distribution of fit uncertainty in u for layer 5



Very preliminary results for the hit efficiency

- currently only counting 2D hits (will be changed to 1D clusters)
- cut on residual: $res./\sigma_{total} < 3$ in u and v; with $\sigma_{total}^2 = \sigma_{digital}^2 + \sigma_{fit}^2$
- "cut and count" for data and compare with counted true hits (MC)

Obtained results for the hit efficiency (very preliminary)

layer	2D hit efficiency		
	from MC	SVD as telescope	PXD+SVD as telesc.
3	0.971 ± 0.001	0.956 ± 0.002	0.986 ± 0.001
4	0.974 ± 0.001	0.987 ± 0.001	0.988 ± 0.001
5	0.978 ± 0.001	0.991 ± 0.001	0.993 ± 0.001
6	0.976 ± 0.001	0.983 ± 0.001	0.989 ± 0.001

- uncertainties statistical only
- currently investigating observed discrepancies

Summary

- measure hit efficiencies might be possible with self tracking approach
- observed residuals heavily biased:
 - self tracking does not work as expected
 - to measure resolutions we do need a (working) telescope

Conclusion

- we do need a "working" telescope

BACKUP

reconstructed v for Layer 5

